Search Notes



Application/Control No.	Applicant(s)/Pate Reexamination	Applicant(s)/Patent under Reexamination	
10/085,394	BATOFF, JEFFREY		
Examiner	Art Unit		
Christopher R. Buchanan	3671		

SEARCHED				
Class	Subclass	Date	Examiner	
705	26	1/22/2007	СВ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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		JH		

SEARCH NO (INCLUDING SEARCE)
	DATE	EXMR
Inventor name search on PALM	1/22/2007	СВ
EAST text search	1/22/2007	СВ
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